

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

HAMADA ET AL.

Examiner

Kevin K. Hill, Ph.D.

Art Unit

1633

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0037278 A1	03-2002	Ueno et al.	424/93.7
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sakai et al, FEBS Letters 456:221-226, 1999
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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